# imall

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FIBER SENSORS

PHOTOELECTRIC SENSORS

LASER SENSORS

MICRO PHOTOELECTRIC SENSORS AREA SENSORS LIGHT CURTAINS / SAFETY PRESSURE / FLOW SENSORS INDUCTIVE PROXIMITY SENSORS

SENSOR OPTIONS SIMPLE WIRE-SAVING UNITS WIRE-SAVING SYSTEMS MEASUREMENT SENSORS

STATIC ELECTRICITY PREVENTION DEVICES

LASER MARKERS

HUMAN MACHINE

FA COMPONENTS

MACHINE VISION SYSTEMS

UV CURING SYSTEMS

Selection Guide Wafer Detectio

Liquid Leak Detection

Liquid Level Detection

Color Mark

Detection Hot Melt Glue

Detection

Ultrasonic

Obstacle Detection

M-DW1

HD-T1

Small / Slim Object Detection

Other Products

Water Detection

INTERFACES ENERGY CONSUMPTION VISUALIZATION COMPONENTS

PLC

# Wafer Mapping Sensor

Related Information

General terms and conditions...... F-7 General precautions ...... P.1458~

Sensor selection guide ...... P.885~

CE

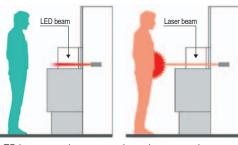
Conforming to EMC Directive



# The safe LED beam reflective type wafer mapping sensor

#### Safe LEDs adopted

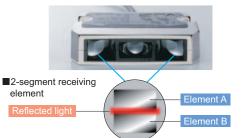
Conventional laser mapping sensor that adopts laser beam has been dangerous because an operator is exposed directly to laser beam, which comes out of the load port through FOUP. We have succeeded in developing LED to adopt as light source for M-DW1. Therefore an operator's safety is ensured.



LED beam mapping sensor Laser beam mapping sensor

## Precise position detection by 2-segment receiving element

Wafer detection by the amount of reflected light may sometimes fail depending on the wafer edge shape. The M-DW1 uses 2-segment receiving element in the beam-receiving part, and detects wafers by the reflected light position instead of the amount of reflected light. Thus, the sensor is less affected by wafer thickness or the amount of reflected light.



# Sensing of nitride-coated wafers possible

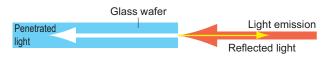
Nitride-coated wafers absorb light at certain wavelengths depending on the coating thickness. If the sensor uses the laser beam having a single wavelength, the beam may be absorbed completely, resulting in wafer detection error. The M-DW1 uses a LED light source with a wide wavelength band that allows to detect nitride-coated wafers successfully.

# High-speed response time: 0.5 ms

The sensor responds in 0.5 ms, meeting the requirements of both high speed and high accuracy in wafer detection.

## Glass wafers are also detectable

The M-DW1, which detects wafers not by the light amount but by the light position, can detect the glass wafers regardless of the light amount.



# Compact and lightweight design with built-in amplifier

The sensor measures W80.6 mm × H18.3 mm × D50 mm W3.173 in × H0.720 in × D1.969 in, and weights only 75 g approx.



# **ORDER GUIDE**

C	RDER GUIDE							
	Appearance		Center sensing distance	Sensing object	Model No.	Output		
		45 mm 1.772 in	3 inch or larger semiconductor wafer	M-DW1	NPN output / PNP output selectable by switch			
S	PECIFICATION	NS						
$\swarrow$	Туре			LED beam	reflective type			
tem	Model No.			N	I-DW1			
cente	r sensing distance			45 m	m 1.772 in			
ensi	ng object			3 inch or larger sem	semiconductor wafer (Note 2)			
etec	table surface	Surface having a side edge which reflects light in the light receiving direction (Note 3)						
ensi	ng angle			12.5 ±	5° (Note 4)			
Vafer	pitch		Separate sens	ing is possible at normal se	nsitivity for 3 mm 0.118	in pitch or more (Note 5)		
uitat	ole cassette			SEMI standard FOU	P cassette / open casse	tte		
uppl	y voltage			12 to 24 V DC ±10 %	6 Ripple P-P 10 % or le	SS		
urre	nt consumption		65 mA or less					
		NPN outp	ut / PNP output, select	able with output selection sv	vitch			
		<npn out<="" td=""><td>put&gt; en-collector transistor</td><td>-</td><td><pnp output=""> PNP open-collect</pnp></td><td>or transistor</td></npn>	put> en-collector transistor	-	<pnp output=""> PNP open-collect</pnp>	or transistor		
Dutpu	t	• Ma:	kimum sink current: 10		<ul> <li>Maximum so</li> </ul>	ource current: 100 mA		
			<ul> <li>Applied voltage: 30 V DC or less (between output and 0 V)</li> <li>Residual voltage: 1 V or less (at 100 mA sink current)</li> <li>Applied voltage: 1 V or less (at 100 mA source current)</li> </ul>					
		• Residual voltage. 1 v or less (at 100 mA sink current) 0.4 V or less (at 16 mA sink current) 0.4 V or less (at 16 mA source current)						
Utilization category DC-12 or DC-13								
(	Output operation	Light-ON / Dark-ON, selectable by switch						
Short-circuit protection Incorporated (restored automatically)								
Response time 500 µs or less								
Operation indicator		Orange LED (lights up when the output is ON)						
stabil	ty indicator		Green LEE	) (lights up under stable ligh	t received condition or s	table dark condition)		
Timer function		Approx. 2 ms fixed OFF-delay timer, switchable either effective or ineffective						
Test input (emission halt input)		Signal condition • Emission Halt: Open, or 4 to 8 V • Emission: 0 to 3 V, or 9 V to +V (26.4 V max.)						
Sensitivity selection input		Signal condition • Input OFF: Open, or 4 to 8 V • Input ON: 0 to 3 V, or 9 V to +V (26.4 V max.)						
Sensi	tivity setting	Back surface teaching: effectuated with sensor's sensitivity setting button Detection sensitivity selection: 4 levels with sensor's 2 bit switch or 2 levels with external input selectable						
I	Pollution degree	3 (Industrial environment)						
	Protection	IP20 (IEC)						
ance	Ambient temperature	0 to +55 °C +32 to +131 °F (No dew condensation), Storage: -10 to +70 °C +14 to +158 °F						
Environmental resistance	Ambient humidity	35 to 85 % RH, Storage: 35 to 85 % RH						
	Ambient illuminance	Incandescent light: 3,000 tx at the light-receiving face, Fluorescent light: 1,500 tx at the light-receiving face						
L men	EMC	EN 60947-5-2						
5	/oltage withstandability	1,000 V AC for one min. between all supply terminals connected together and enclosure						
	nsulation resistance	20 MΩ, or more, with 250 V DC megger between all supply terminals connected together and enclosure						
`	/ibration resistance	10 to 500 Hz frequency, 3 mm 0.118 in amplitude in X, Y and Z directions for two hours each						
:	Shock resistance	98 m/s <sup>2</sup> acceleration (10 G approx) in X, Y and Z directions for five times each						
Emitting element		LED (modulated)						
Material		Enclosure: ABS and Stainless steel (SUS301), Lens: Acrylic						
Cable		0.15 mm <sup>2</sup> 5-core cabtyre cable, 300 mm 11.811 in long						
Cable extension		Extension up to total 10 m 32.808 ft is possible with 0.15 mm <sup>2</sup> , or more, cable.						
Weigh					nt: 75 g approx.			

2) In case of 8 inch or less wafers, the wafer pitch, the orientation flat or surface condition may affect the sensing.

3) Polished wafers, etc., which have a sharp edge cannot be detected since they do not reflect the light in the light receiving direction. 4) Since the position of the orientation flat may vary by ±20° due to its rotation, refer to "Detecting wafer having orientation flat (p.890)" for detection of a

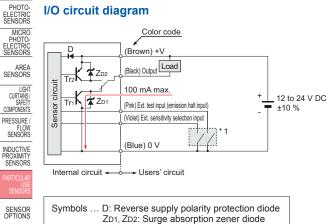
wafer having an orientation flat. 5) This is the pitch of an 8 inch wafer near its center region when it is inserted in an inclined fashion. When detecting a wafer having an orientation flat, the wafer pitch becomes still smaller when sensing at positions which avoid the orientation flat. In this case, the sensing signal cannot be resolved and it becomes a continuous, broad signal. For details, refer to "Sensing signal (p.891)".

FIBER SENSORS

I/O CIRCUIT DIAGRAMS



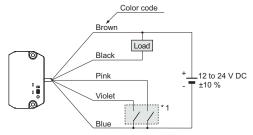
## I/O circuit diagram



Tr1: NPN output transistor

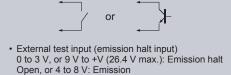
Tr2: PNP output transistor

# Wiring diagram



\* 1

Non-voltage contact or NPN open-collector transistor



External sensitivity selection input 0 to 3 V, or 9 V to +V (26.4 V max.): Input ON Open, or 4 to 8 V: Input OFF

# PNP output



Selection Guide Wafe Detection

Liquid Leak Detection Liquid Level

Water Detection

Color Mark Detection Hot Melt Glue Detection Ultrasonic Small / Slim Object Detection

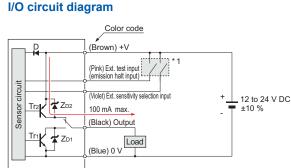
SIMPLE WIRE-SAVING UNITS

WIRE-SAVING SYSTEMS

MEASURE-MENT SENSORS

STATIC ELECTRICITY PREVENTION DEVICES LASER MARKERS

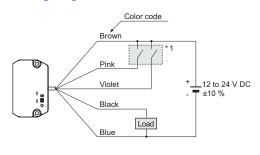
PLC



Internal circuit -- Users' circuit

Symbols D: Reverse supply polarity protection diode
ZD1, ZD2: Surge absorption zener diode
Tr1: NPN output transistor
Tr2: PNP output transistor

#### Wiring diagram



\* 1

Non-voltage contact or PNP open-collector transistor or

- · External test input (emission halt input) 0 to 3 V, or 9 V to +V (26.4 V max.): Emission halt Open, or 4 to 8 V: Emission
- External sensitivity selection input 0 to 3 V, or 9 V to +V (26.4 V max.): Input ON Open, or 4 to 8 V: Input OFF

# PRECAUTIONS FOR PROPER USE

Never use this product as a sensing device for personnel protection.
In case of using sensing devices for

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personnel protection, use products which meet laws and standards, such as OSHA, ANSI or IEC etc., for personnel protection applicable in each region or country.

#### Mounting

 Set the distance between the sensor detection surface and the wafer edge to be 45 mm 1.772 in and mount the sensor so that sensing is done at an angle of 12.5° with respect to the wafer. Mount using M4 (length 16 mm 0.630 in) screws. The tightening torque should be 1.2 N·m or less. Further, although the sensing distance may change due to variation in the wafer position (wafer protrusion, orientation flat position, etc.), if it is within 5 mm 0.197 in, stable sensing is possible.



Note: If the wafer center axis and the sensor axis lie along a straight line  $(0^{\circ})$ , detection is not possible. Always mount the sensor at an angle to the wafer.

#### Wiring

**Top-view** 

- Make sure that the power supply is off while wiring.
- · Take care that wrong wiring will damage the product.
- · Verify that the supply voltage variation is within the rating.
- If power is supplied from a commercial switching regulator, ensure that the frame ground (F.G.) terminal of the power supply is connected to an actual ground.
- In case noise generating equipment (switching regulator, inverter motor, etc.) is used in the vicinity of this product, connect the frame ground (F.G.) terminal of the equipment to an actual ground.
- Do not run the wires together with high-voltage lines or power lines or put them in the same raceway. This can cause malfunction due to induction.
- Extension up to total 10 m 32.808 ft, or less, is possible with 0.15 mm<sup>2</sup>, or more, cable. However, in order to reduce noise, make the wiring as short as possible.
- Make sure to use an isolation transformer for the DC power supply. If an autotransformer (single winding transformer) is used, this product or the power supply may get damaged.
- In case a surge is generated in the used power supply, connect a surge absorber to the supply and absorb the surge.

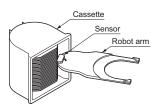
#### Others

- Do not use during the initial transient time (0.5 sec.) after the power supply is switched on.
- Take care that the sensor is not directly exposed to fluorescent lamp from a rapid-starter lamp, a high frequency lighting device or sunlight etc., as it may affect the sensing performance.
- · Avoid dust, dirt, and steam.
- Take care that the product does not come in contact with water, oil, grease or organic solvents, such as, thinner, etc.
- Do not allow any water, oil, fingerprints, etc., which may refract light, or dust, dirt, etc., which may block light, to stick to the sensing surfaces of the sensor. In case they are present, wipe them with a clean, dust-free soft cloth or lens paper.

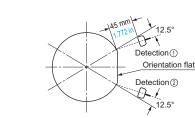
Refer to p.1458~ for general precautions.

#### Detecting wafer having orientation flat

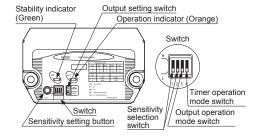
• When detecting a wafer having an orientation flat, mount the sensor so that a portion other than the orientation flat is detected. Further, arrange to detect the wafer from two different angles by moving the robot arm, etc., and OR the signal so obtained.







#### **Part description**



#### Sensitivity selection setting

 Sensitivity can be selected from four levels by appropriate setting of the sensitivity selection switch (2 bits).



Sensitivity selection switch		Sensitivity
	Maximum sensitivity (MAX)	Used for low reflectivity wafers with nitride or oxide film processing,or for thin wafers (0.3 to 0.4 mm 0.012 to 0.016 in)
	High sensitivity (HIGH)	Sensitivity between maximum sensitivity and medium sensitivity
H L 1 2 3 4	Medium sensitivity (MID)	Used for high reflectivity polished wafers, etc., or for 3 mm 0.118 in wafer pitch
H L 1 2 3 4	Low sensitivity (LOW)	Lowest possible sensitivity setting

Notes: 1) In case of 8 inch or less wafers, the wafer pitch, orientation flat or the surface condition may affect the sensing.

 Polished wafers, etc., which have a sharp edge cannot be detected since they do not reflect the light in the light receiving direction.



WIRE-SAVING SYSTEMS

MEASURE-MENT SENSORS

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FA COMPONENTS

MACHINE VISION SYSTEMS

UV CURING SYSTEMS FIBER SENSORS

# PRECAUTIONS FOR PROPER USE

#### External sensitivity selection input

 The external sensitivity selection input (violet) becomes ON when it is connected to 0 to 3 V, or 9 V to +V (26.4 V max.), and becomes OFF when it is kept open or connected to 4 to 8 V.

If the sensitivity is selected with the external sensitivity selection input, set the sensitivity selection switch as shown in the table below.

Sensitivity selection switch	Ext. sensitivity sele	Sensitivity	
	0 to 3 V, or 9 V to +V (26.4 V max.)	ON	Maximum sensitivity (MAX)
	Open, or 4 to 8 V	OFF	Medium sensitivity (MID)
	0 to 3 V or 9 V to +V (26.4 V max.)	ON	High sensitivity (HIGH)
	Open, or 4 to 8 V	OFF	Low sensitivity (LOW)

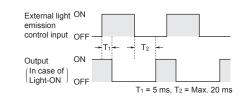
#### Sensitivity setting

- Although this sensor has an optical system which makes it difficult for the background to affect the detection, the background may have an effect when detecting small diameter wafers. Hence, if the background gets detected, or the stability indicator (green) lights off when the cassette has no wafers, sensitivity setting should be done so that the background does not have an effect. However, the sensitivity reduces when sensitivity setting is done.
- Since the sensitivity is stored in an EEPROM when the sensitivity setting button is pressed, the setting need not be repeated when the power is switched on again. However, note that the EEPROM has a lifetime and its guaranteed life is 100,000 write operation cycles.

#### Light emission control function

 Light emission is halted when the external light emission control input (pink) is connected to 0 to 3 V, or 9 V to +V (26.4 V max.). In this case, the output turns to the dark state.

Time chart



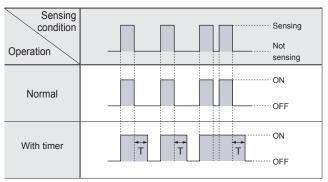
#### Refer to p.1458~ for general precautions.

#### Timer function

• Using the timer operation mode switch, it is possible to select an approx. 2 ms fixed OFF-delay timer. Since the output is extended by a fixed period, it is useful when the connected device has a slow response time.



#### Time chart

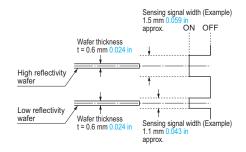


Timer period: T = Approx. 2 ms

#### Sensing signal

#### Sensing signal width

- The sensing signal which is output from the sensor is as follows: The sensing signal has a width larger than the thickness of the wafer.
- The signal width also varies with the reflectivity of the sensing edge.
- High reflectivity (polish, aluminum evaporated, etc.): Large signal width Example: Wafer thickness t = 0.6 mm 0.024 in Signal width Low reflectivity (nitride or oxide film processed): Small signal width
- Example: Wafer thickness t = 0.6 mm 0.024 in Signal width 1.1 mm 0.043 in approx.
- ③The signal width also changes with the sensing distance or the sensing angle.



 From the above, for determining the position of the wafer from the sensing signal, calculate the center position of the signal's ON region, while taking into consideration the response time.

Selection Guide

Wafe Detection

Liquid Leak

Liquid Level

Water Detection

Color Mark Detection

Hot Melt Glue

Ultrasonio

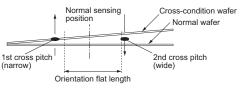
Small / Slim Object Detection

Obstacle Detection Other Products

# PRECAUTIONS FOR PROPER USE

#### Narrow pitch sensing signal width

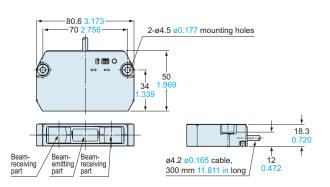
• In case of "Detecting wafer having orientation flat (p.890)", when the sensor is mounted at positions which avoid the wafer orientation flat, the pitch of a crosscondition wafer changes as shown in the figure below.



 The calculated pitch based on the wafer size is given in the table below.

Wafer size	Normal pitch	Orientation flat length	Wafer thickness	Cross pitch (narrow)	Cross pitch (wide)
3 inch	4.75 mm	22.2 mm	0.380 mm	1.58 mm	3.17 mm
(75 mm 2.953 in)	0.187 in	0.874 in	0.015 in	0.062 in	0.125 in
4 inch	4.75 mm	32.5 mm	0.625 mm	1.54 mm	3.21 mm
(100 mm 3.937 in)	0.187 in	1.280 in	0.025 in	0.061 in	0.126 in
5 inch	4.75 mm	42.5 mm	0.625 mm	1.52 mm	3.23 mm
(125 mm 4.921 in)	0.187 in	1.673 in	0.025 in	0.060 in	0.127 in
6 inch	4.75 mm	57.5 mm	0.675 mm	1.43 mm	3.33 mm
(150 mm <u>5.906 in</u> )	0.187 in	2.264 in	0.027 in	0.056 in	0.131 in
8 inch	6.35 mm	59.3 mm	0.725 mm	2.19 mm	4.16 mm
(200 mm 7.874 in)	0.250 in	2.335 in	0.029 in	0.086 in	0.164 in

# DIMENSIONS (Unit: mm in)



Refer to p.1458~ for general precautions.

- From the above, it is seen that, since the pitch of the cross-condition wafer reduces, the pitch resolution required for high reflectivity wafers becomes more stringent than the specified resolution of 3 mm 0.118 in. Hence, the sensing signal from two wafers may not be resolved and may become a continuous signal.
   Further, the sensing signal may also change due to the sensitivity setting, the reflectivity of the wafer, and the sensing conditions (sensing distance or sensing angle). For the above reasons, in case of wafers which have been cross-inserted, since the small cross-pitch side is similar to overlapping wafers, the sensing signal of two wafers may become a continuous signal or may get resolved.
- If the orientation flat happens to get in the position of sensing, sensing is not possible in one of the two sensing positions. Therefore, if the wafer is cross-inserted, a resolved signal may not be output, and in this case, the information on the wafer position calculated from the sensing signal will be erroneous.

The CAD data in the dimensions can be downloaded from our website.

FIBER SENSORS

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AREA SENSORS

LIGHT CURTAINS / SAFETY COMPONENTS

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SENSOR OPTIONS

HD-T1